Search Notes		

Application/Co	ntrol No.	Applicant(s)/Patent under Reexamination	
10/648,513		NISHIMURA E	ET AL.
Examiner		Art Unit	
Jim Vannucci		2828	

SEARCHED			
Class	Subclass	Date	Examiner
372	38.02	6/8/2005	٦٧
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
bias, I/V conversion, comparator, maximum, average	6/8/2005	JV